

# N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	$I_D(A)^{a, e}$				
60	$0.023$ at $V_{GS} = 10 \text{ V}$	50	66 nC			
60	0.027 at V <sub>GS</sub> = 4.5 V	40	00 110			

#### **FEATURES**

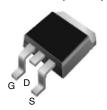
- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

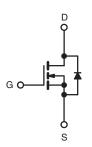


COMPLIANT HALOGEN









N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	$V_{DS}$	60	V			
Gate-Source Voltage			$V_{GS}$	± 10	V	
Continuous Drain Current <sup>f</sup>	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$	L	50	А	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	36		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200		
Linear Derating Factor				1.0	- W/°C	
Linear Derating Factor (PCB Mount)e	,	0.025	VV/ C			
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	400	mJ			
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		0	150	W	
Maximum Power Dissipation (PCB Mount)e	T <sub>A</sub> = 25 °C		$P_{D}$	3.7		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup> for 10 s			300 <sup>d</sup>			

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 25$  V, starting  $T_J = 25$  °C, L = 179  $\mu$ H,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 51$  A (see fig. 12). c.  $I_{SD} \le 51$  A,  $I_{AS} = 51$

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).
- f. Current limited by the package, (die current = 51 A).



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0			

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	L TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static				Į	<u>J</u>		ļ	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$ , $I_D = 250 \mu A$		60	_	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$		1.0	-	3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 10 V		-	-	± 100	nA	
7 0		V <sub>DS</sub> :	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	25		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48 V,	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μA	
Durin On the On Old Braiden	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 21 A <sup>b</sup>	-	23	-		
Drain-Source On-State Resistance		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 15 A <sup>b</sup>	-	27	-	Ω	
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 21A b		23	-	-	S	
Dynamic								
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	3000	-	pF	
Output Capacitance	C <sub>oss</sub>			-	1000	-		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	200	-		
Total Gate Charge	Qg			-	60	-		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5.0 V	$V_{GS} = 5.0 \text{ V}$ $I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		10	-	nC	
Gate-Drain Charge	$Q_{gd}$			-	40	-		
Turn-On Delay Time	t <sub>d(on)</sub>			-	17	-		
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 51 A,		-	230	-	- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 4.6 \Omega$ , $R_D = 0.56 \Omega$ , see fig. 10 <sup>b</sup>		-	42	-		
Fall Time	t <sub>f</sub>	1		-	110	-		
Internal Drain Inductance	$L_{D}$	Between lead, 6 mm (0.25") from		-	4.5	-	ьЦ	
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	- nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	50°	- A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	200		
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 51 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 51 A, dl/dt = 100 A/µs <sup>b</sup>		-	130	180	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-		on is dor	minated b	y L <sub>S</sub> and	L <sub>D</sub> )	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
  b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
  c. Current limited by the package, (Die Current = 51 A).



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

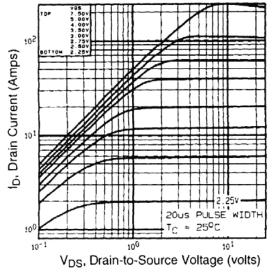


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

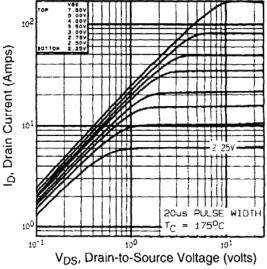


Fig. 2 - Typical Output Characteristics,  $T_C = 150 \, ^{\circ}\text{C}$ 

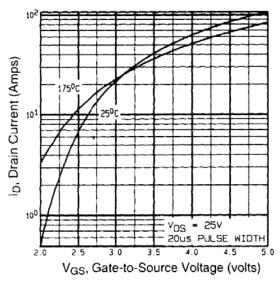


Fig. 3 - Typical Transfer Characteristics

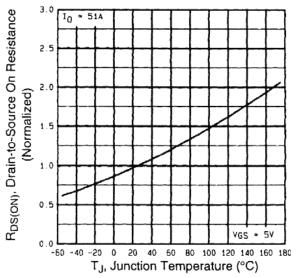


Fig. 4 - Normalized On-Resistance vs. Temperature



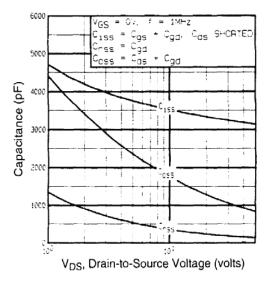


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

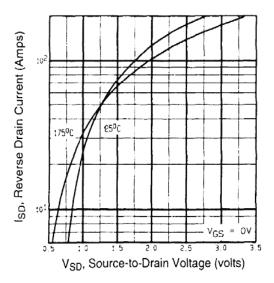


Fig. 7 - Typical Source-Drain Diode Forward Voltage

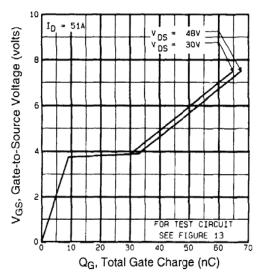


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

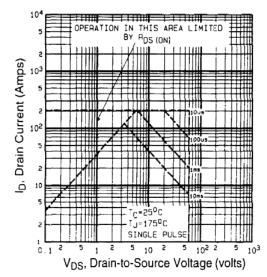


Fig. 8 - Maximum Safe Operating Area



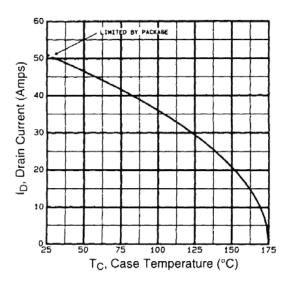


Fig. 9 - Maximum Drain Current vs. Case Temperature

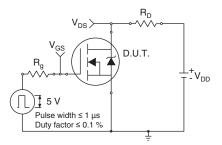


Fig. 10a - Switching Time Test Circuit

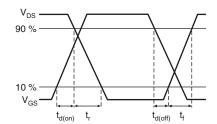


Fig. 10b - Switching Time Waveforms

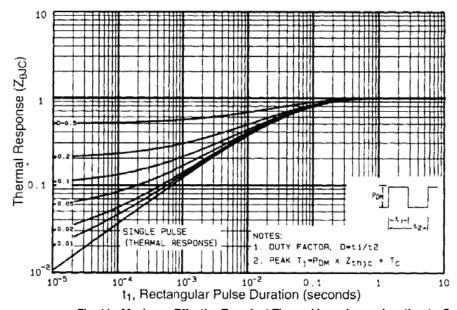
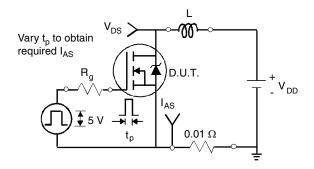


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





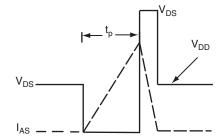


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

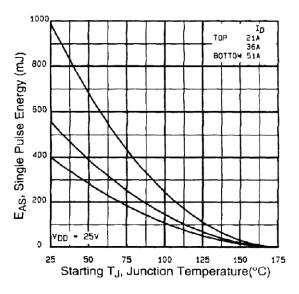


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

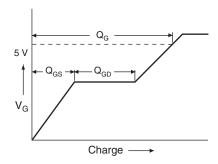


Fig. 13a - Basic Gate Charge Waveform

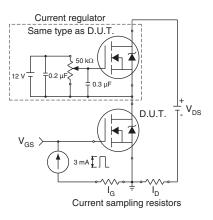
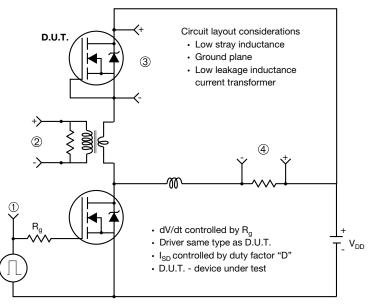


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



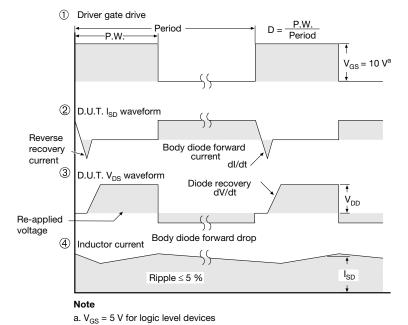
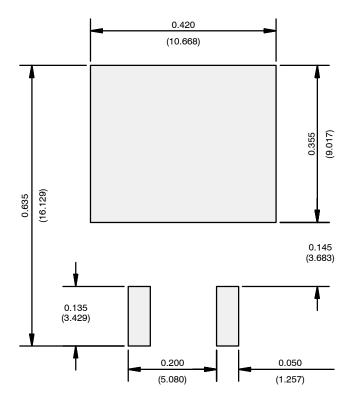


Fig. 14 - For N-Channel



### RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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